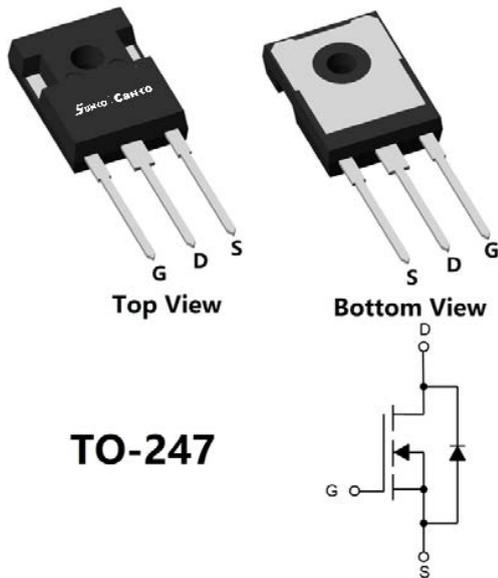


## N-Channel Enhancement Mode Field Effect Transistor



**TO-247**

### Product Summary

- $V_{DS}$  200V
- $I_D$  98A
- $R_{DS(ON)}$  ( at  $V_{GS}=10V$ )  $< 11.5m\Omega$
- 100% EAS Tested
- 100%  $\nabla V_{DS}$  Tested

### General Description

- Excellent package for heat dissipation
- High density cell design for low  $R_{DS(ON)}$
- Epoxy Meets UL 94 V-0 Flammability Rating
- Halogen Free

### Applications

- UPS and Inverter applications
- Motor drivers
- DC-DC convertor

### Limiting Values

Parameter	Conditions		Symbol	Min	Max	Unit
Drain-source Voltage			$V_{DS}$	-	200	V
Gate-source Voltage			$V_{GS}$	-20	20	
Continuous Drain Current (Note 1,2)	Steady-State	$T_A=25^\circ C, V_{GS}=10V$	$I_D$	-	10.5	A
		$T_A=100^\circ C, V_{GS}=10V$		-	6.6	
Continuous Drain Current (Note 1,3)	Steady-State	$T_C=25^\circ C, V_{GS}=10V, \text{Chip limitation}$		-	98	
		$T_C=100^\circ C, V_{GS}=10V$		-	62	
Pulsed Drain Current	$T_C=25^\circ C, t_p \leq 10\mu s$		$I_{DM}$	-	392	
Maximum Body-Diode Continuous Current	$T_C=25^\circ C$		$I_S$		98	
Avalanche energy (non-repetitive )	$T_J=25^\circ C, V_G=10V, R_G=25\Omega, L=0.5mH, I_{AS}=50A$		EAS	-	625	mJ
Total Power Dissipation (Note 1,2)	Steady-State	$T_A=25^\circ C$	$P_D$	-	2.97	W
		$T_A=100^\circ C$		-	1.19	
Total Power Dissipation (Note 1,3)	Steady-State	$T_C=25^\circ C$		-	260	
		$T_C=100^\circ C$		-	104	
Junction and Storage Temperature Range			$T_J, T_{STG}$	-55	150	$^\circ C$

### Thermal Resistance

Parameter		Symbol	Typ	Max	Units
Thermal Resistance Junction-to-Ambient (Note 2)	Steady-State	$R_{\theta JA}$	-	42	$^\circ C/W$
Thermal Resistance Junction-to-Case	Steady-State	$R_{\theta JC}$	-	0.48	

### Ordering Information (Example)

PREFERRED P/N	PACKING CODE	Marking	MINIMUM PACKAGE(pcs)	INNER BOX QUANTITY(pcs)	OUTER CARTON QUANTITY(pcs)	DELIVERY MODE
SCW012G20H	B1	SCW012G20H	30	360	1800	Tube

## ■ Electrical Characteristics

Parameter	Symbol	Conditions	Min	Typ	Max	Units
<b>Static Parameter</b>						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA, T <sub>j</sub> =25°C	200	-	-	V
		V <sub>GS</sub> =0V, I <sub>D</sub> =1mA, T <sub>j</sub> =25°C	200	-	-	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =200V, V <sub>GS</sub> =0V, T <sub>j</sub> =25°C	-	-	1	μA
		V <sub>DS</sub> =200V, V <sub>GS</sub> =0V, T <sub>j</sub> =125°C	-	-	100	
Gate-Source Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V, T <sub>j</sub> =25°C	-	-	±100	nA
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA, T <sub>j</sub> =25°C	2.2	3	3.8	V
Static Drain-Source On-Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =50A, T <sub>j</sub> =25°C	-	9.7	11.5	mΩ
Diode Forward Voltage	V <sub>SD</sub>	I <sub>S</sub> =50A, V <sub>GS</sub> =0V, T <sub>j</sub> =25°C	-	0.86	1.2	V
Gate Resistance	R <sub>G</sub>	f=1MHz, T <sub>j</sub> =25°C	-	0.8	-	Ω
<b>Dynamic Parameters</b>						
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> =100V, V <sub>GS</sub> =0V, f=1MHz, T <sub>j</sub> =25°C	-	3920	-	pF
Output Capacitance	C <sub>oss</sub>		-	445	-	
Reverse Transfer Capacitance	C <sub>rss</sub>		-	11.3	-	
<b>Switching Parameters</b>						
Total Gate Charge	Q <sub>g</sub>	V <sub>GS</sub> =10V, V <sub>DS</sub> =100V, I <sub>D</sub> =50A, T <sub>j</sub> =25°C	-	50.5	-	nC
Gate-Source Charge	Q <sub>gs</sub>		-	18.4	-	
Gate-Drain Charge	Q <sub>gd</sub>		-	8.2	-	
Reverse Recovery Charge	Q <sub>rr</sub>	I <sub>F</sub> =50A, di/dt=100A/μs, V <sub>GS</sub> =0V, V <sub>R</sub> =100V, T <sub>j</sub> =25°C	-	513	-	nC
Reverse Recovery Time	t <sub>rr</sub>		-	135	-	ns
Turn-on Delay Time	t <sub>D(on)</sub>	V <sub>GS</sub> =10V, V <sub>DS</sub> =100V, I <sub>D</sub> =50A, R <sub>GEN</sub> =3Ω, T <sub>j</sub> =25°C	-	20	-	ns
Turn-on Rise Time	t <sub>r</sub>		-	42	-	
Turn-off Delay Time	t <sub>D(off)</sub>		-	32	-	
Turn-off Fall Time	t <sub>f</sub>		-	9	-	

- Note:
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
  - The value of R<sub>θJA</sub> is measured in the still air environment with T<sub>A</sub>=25°C. The maximum allowed junction temperature of 150°C.
  - Thermal resistance from junction to soldering point (on the exposed drain pad).

■ Typical Electrical and Thermal Characteristics Diagrams

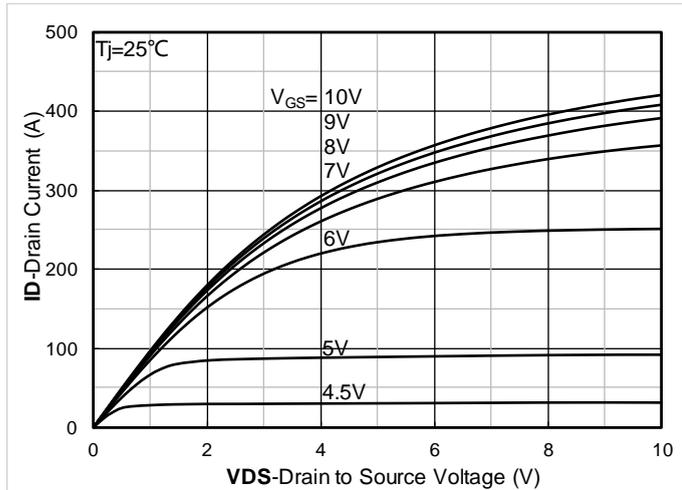


Figure 1. Output Characteristics; typical values

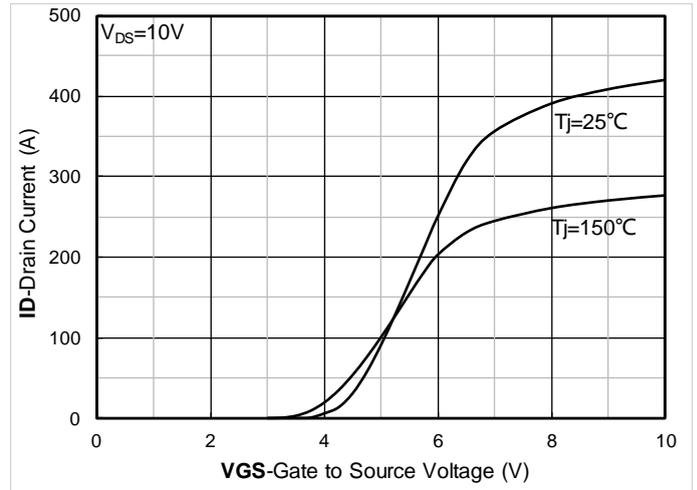


Figure 2. Transfer Characteristics; typical values

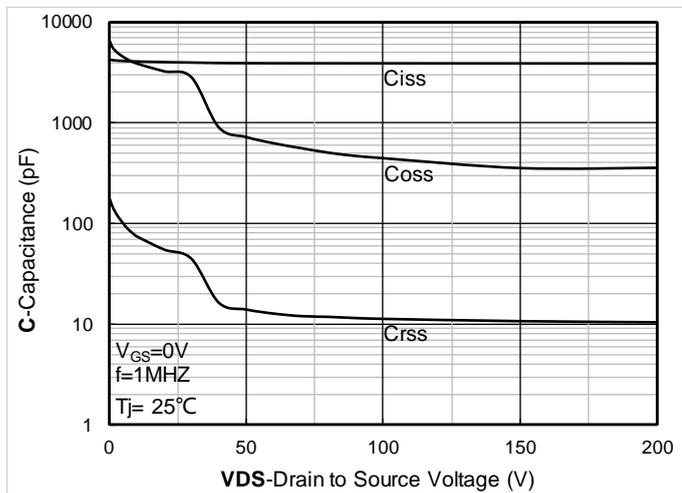


Figure 3. Capacitance Characteristics; typical values

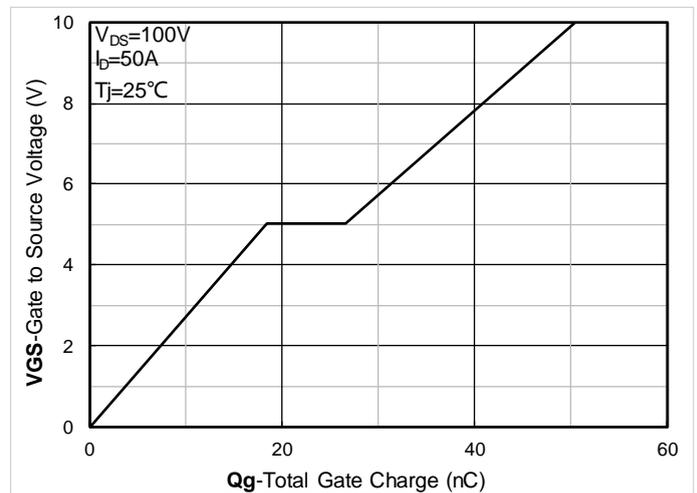


Figure 4. Gate Charge; typical values

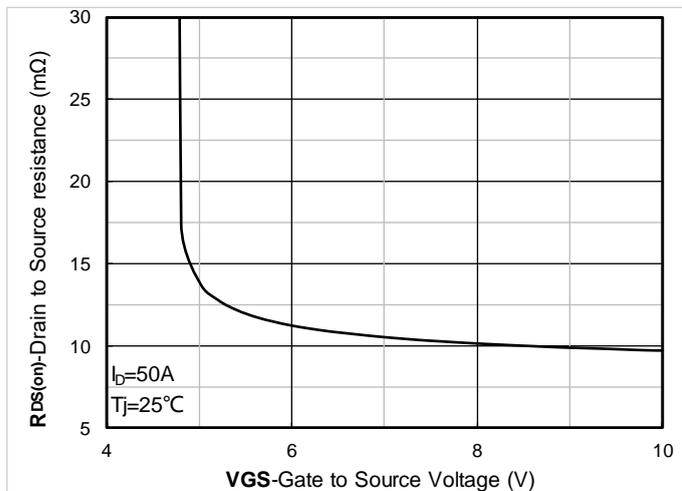


Figure 5. On-Resistance vs Gate to Source Voltage; typical values

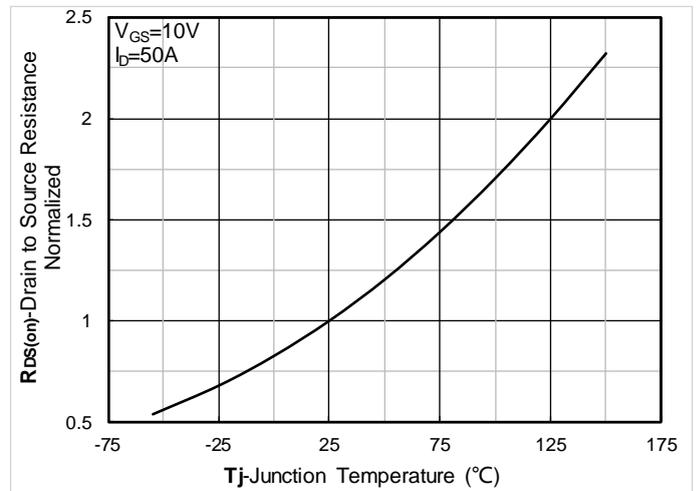


Figure 6. Normalized On-Resistance

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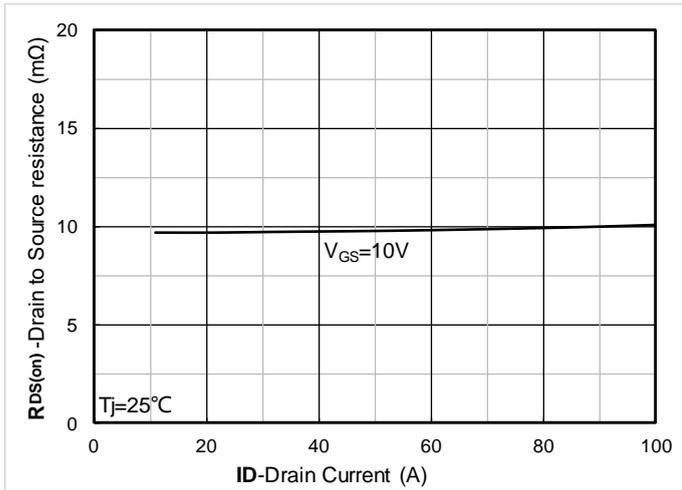


Figure 7. RDS(on) VS Drain Current; typical values

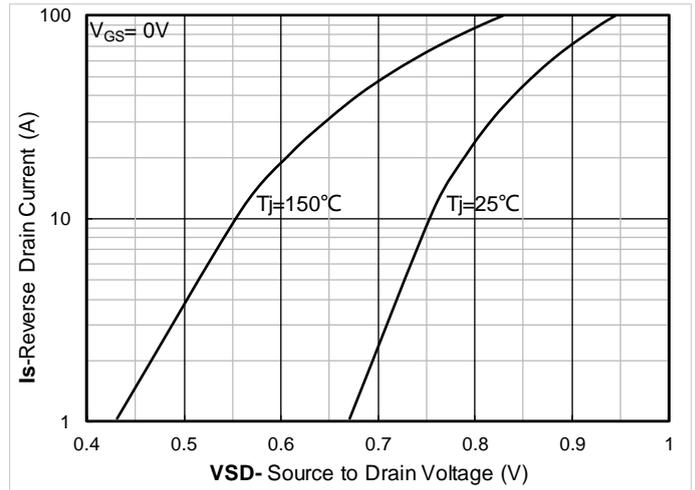


Figure 8. Forward characteristics of reverse diode; typical values

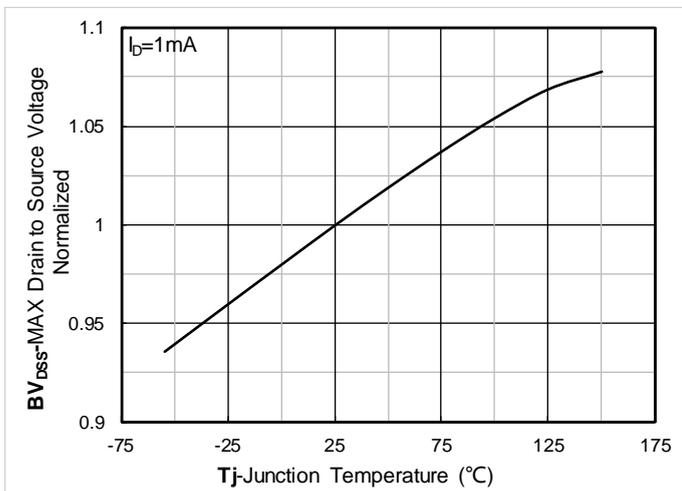


Figure 9. Normalized breakdown voltage

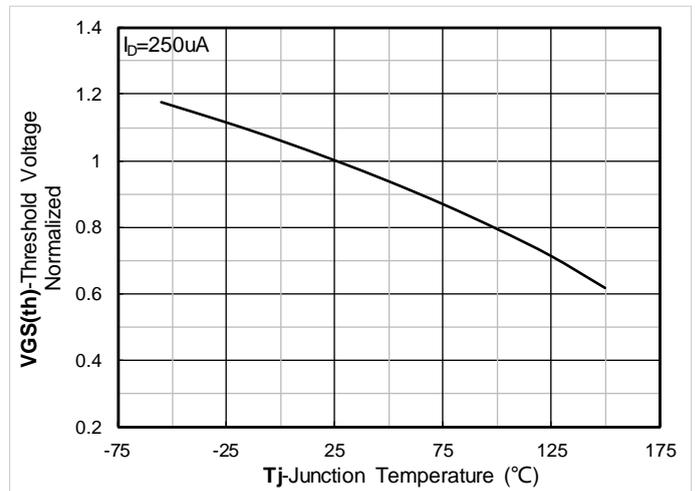


Figure 10. Normalized Threshold voltage

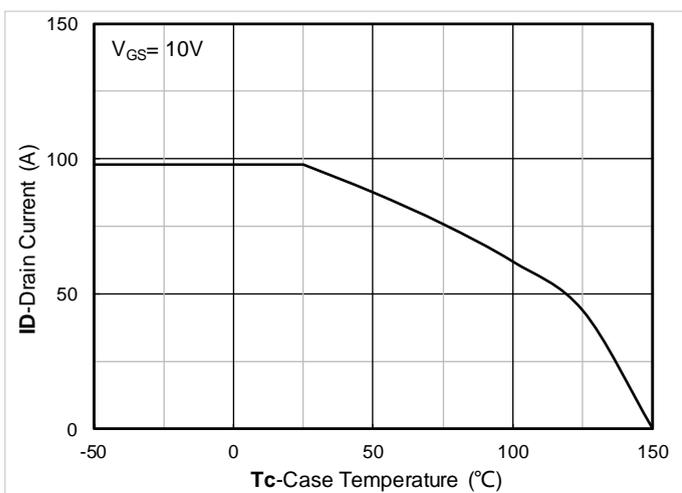


Figure 11. Current dissipation

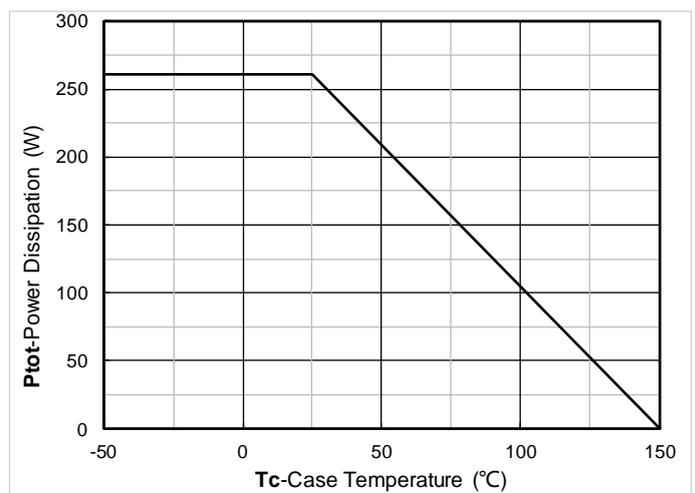


Figure 12. Power dissipation

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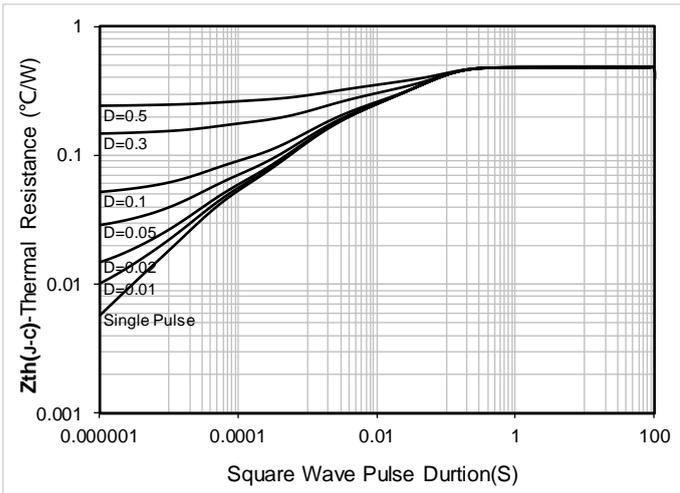


Figure 13. Maximum Transient Thermal Impedance

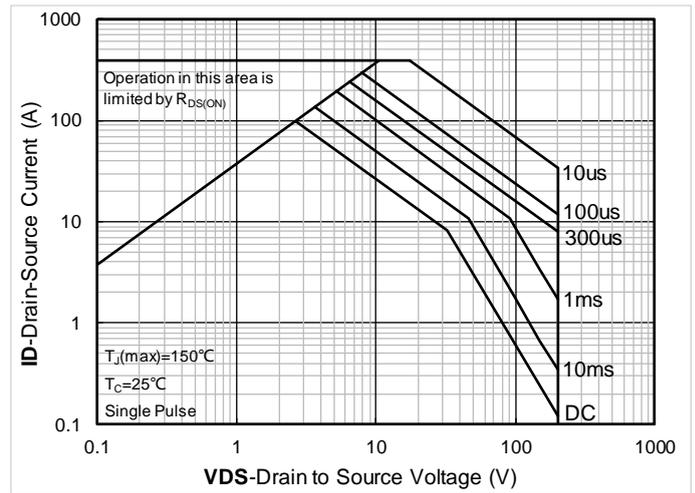


Figure 14. Safe Operation Area

■ Test Circuits & Waveforms

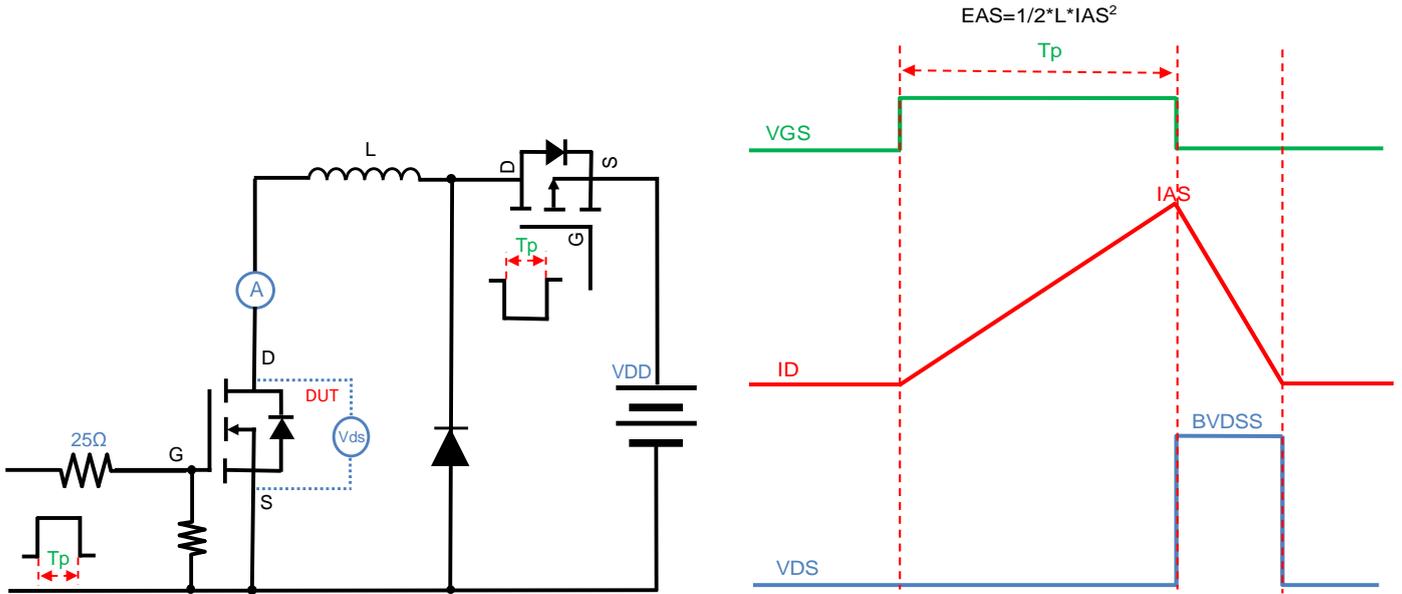


Figure A. Unclamped Inductive Switching (UIS) Test Circuit & Waveform

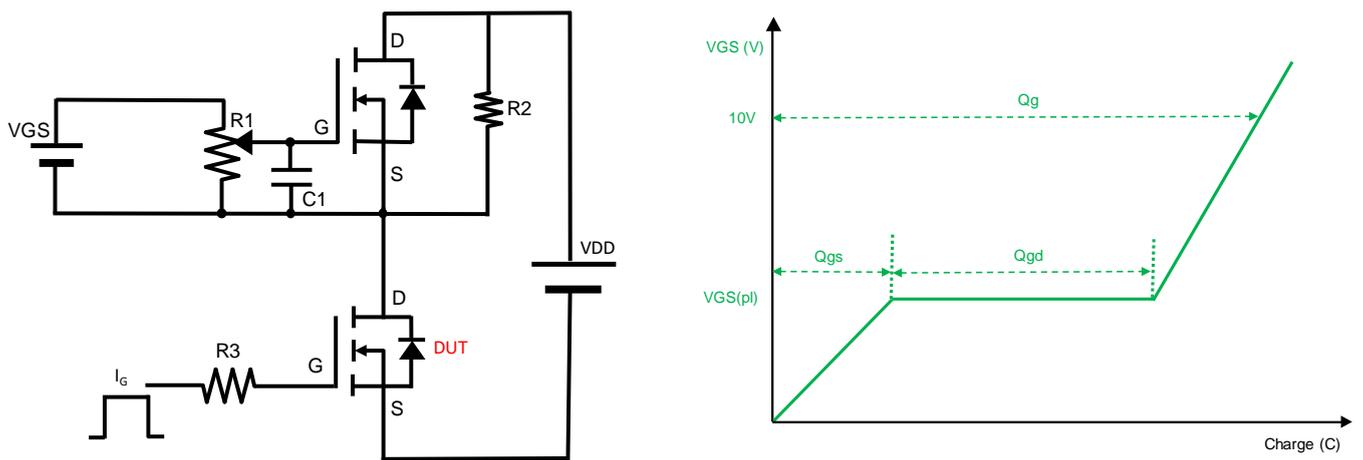


Figure B. Gate Charge Test Circuit & Waveform

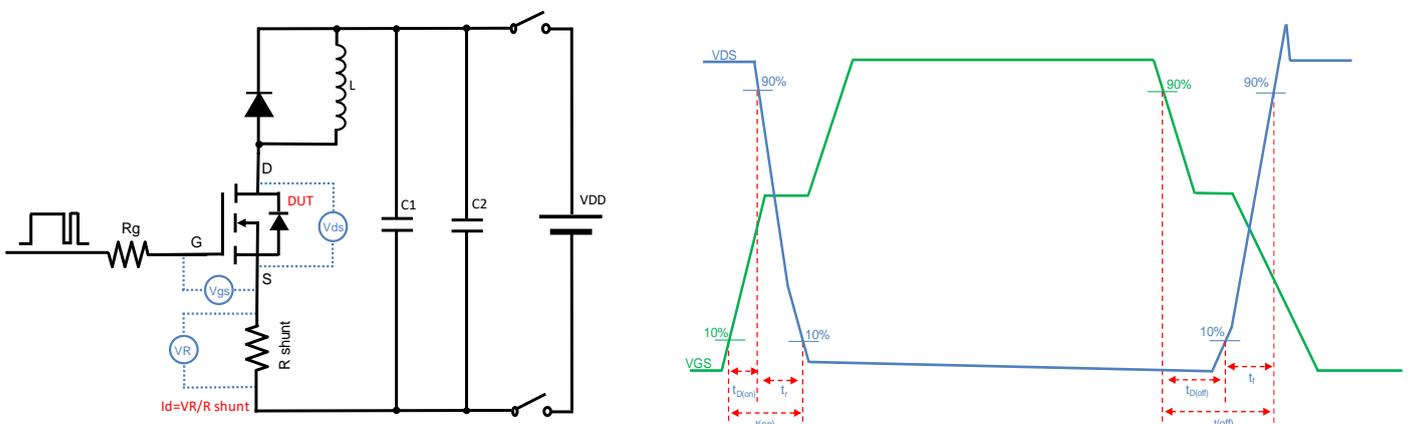


Figure C. Resistive Switching Test Circuit & Waveform

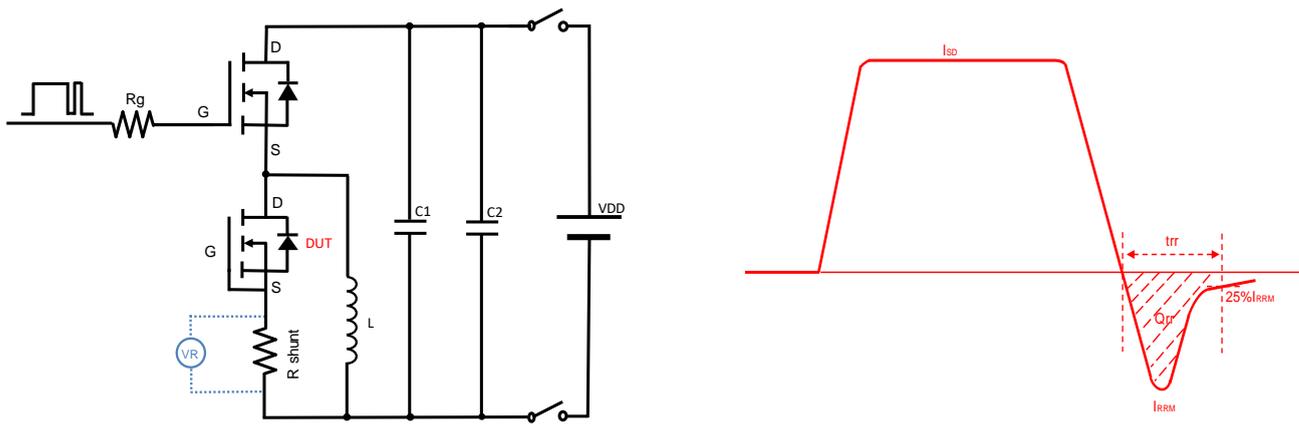
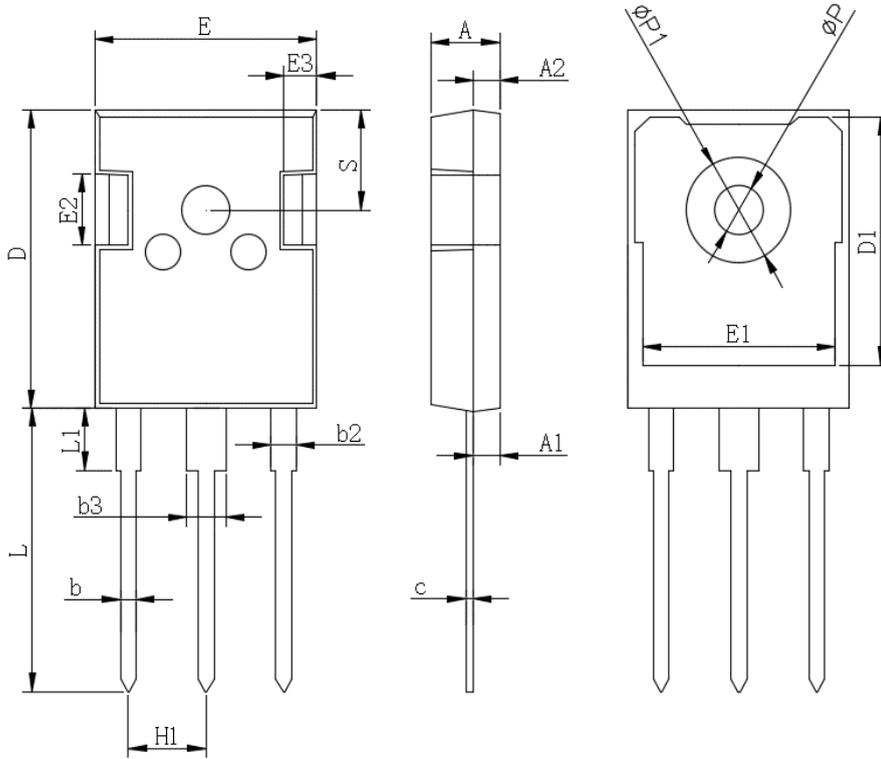


Figure D. Diode Recovery Test Circuit & Waveform

■ TO-247AB Package information

TO-247AB



TO-247AB		
Dim	Min	Max
A	4.80	5.20
A1	2.21	2.61
A2	1.85	2.15
b	1.0	1.4
b2	1.91	2.21
c	0.5	0.7
D	20.70	21.30
D1	16.25	16.85
E	15.50	16.10
E1	13.0	13.6
E2	4.80	5.20
E3	2.30	2.70
L	19.62	20.22
L1	-	4.30
$\phi P$	3.40	3.80
$\phi P1$	-	7.30
S	6.15TYP	
H1	5.44TYP	
b3	2.80	3.20

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